

# **Product Specification**

# XBLW FDS4435BZ

P-Channel Enhancement Mode MOSFET











## **Description**

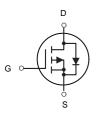
The FDS4435BZ uses advanced trench technology to provide excellent RDS(ON), low gate charge and operation with gate voltages as low as 2.5V. This device is suitable for use as a Battery protection or in other Switching application.

#### **General Features**

- ➤ VDS =-30V ID = -11A
- $\triangleright$  RDS(ON) < 16m $\Omega$  @ VGS=10V

## **Application**

- Battery protection
- Load switch
- Uninterruptible power supply



#### P-Channel MOSFET

## **Package Marking and Ordering Information**

Product Model	Package Type	Marking	Packing	Packing Qty
XBLW FDS4435BZ	SOP-8	FDS4435	Tape	3000Pcs/Reel

## Absolute Maximum Ratings (Tc=25°C unless otherwise noted )

Symbol	Parameter	Rating	Units
$V_{DS}$	Drain-Source Voltage	- 30	V
VGS	Gate-Source Voltage	±20	V
ID@TA=25°C	Drain Current <sup>3</sup> , V <sub>GS</sub> @ 10V	-11	А
IDM	Pulsed Drain Current <sup>1</sup>	-40	Α
PD@TA=25°C	Total Power Dissipation	3.7	W
TSTG	Storage Temperature Range	-55 to 150	°C
TJ	Operating Junction Temperature Range	-55 to 150	°C
Rthj-a	Maximum Thermal Resistance, Junction-ambient <sup>3</sup>	33.8	°C/W



## **Electrical Characteristics (TJ = 25°C, unless otherwise noted)**

Symbol	Parameter	Test Condition	Min.	Тур.	Max.	Units
Off Charac	cteristic			,		
V <sub>(BR)DSS</sub>	Drain-Source Breakdown Voltage	V <sub>GS</sub> =0V, I <sub>D</sub> = -250μA	-30	-	-	V
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	V <sub>DS</sub> = -30V, V <sub>GS</sub> =0V,	-	-	-1	μA
I <sub>GSS</sub>	Gate to Body Leakage Current	V <sub>DS</sub> =0V, V <sub>GS</sub> = ±20V	-	-	±100	nA
On Charac	teristics					
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS}=V_{GS}$ , $I_D=-250\mu A$	-1.0	-1.6	-2.5	V
Б	Static Drain-Source on-Resistance	V <sub>GS</sub> = -10V, I <sub>D</sub> = -10A	-	13	16	<b>~</b> 0
$R_{DS(on)}$	Note3	V <sub>GS</sub> = -4.5V, I <sub>D</sub> = -5A	-	18	27	mΩ
Dynamic C	Characteristics					
C <sub>iss</sub>	Input Capacitance	\/ - 45\/ \/ -0\/	-	1330	-	рF
Coss	Output Capacitance	$V_{DS}$ = -15V, $V_{GS}$ =0V, f=1.0MHz	-	183	-	pF
C <sub>rss</sub>	Reverse Transfer Capacitance	1-1.01VII 12	-	156	-	рF
Qg	Total Gate Charge	\/ 4E\/_	-	22	-	nC
Q <sub>gs</sub>	Gate-Source Charge	V <sub>DS</sub> = -15V, I <sub>D</sub> = -5A, V <sub>GS</sub> = -10V	-	1.0	-	nC
$Q_gd$	Gate-Drain("Miller") Charge	V GS — 10 V	1	1.8	-	nC
Switching	Characteristics					
t <sub>d(on)</sub>	Turn-on Delay Time		-	9	-	ns
t <sub>r</sub>	Turn-on Rise Time	$V_{DD}$ = -15V, $I_{D}$ = -10A,	ı	13	-	ns
t <sub>d(off)</sub>	Turn-off Delay Time	$V_{\text{GS}}\text{=-}10V,\ R_{\text{GEN}}\text{=}2.5\Omega$	-	48	-	ns
t <sub>f</sub>	Turn-off Fall Time		-	20	-	ns
Drain-Sou	rce Diode Characteristics and Maximu	ım Ratings				
Is	Maximum Continuous Drain to Source Diode Forward Current		-	-	-11	Α
I <sub>SM</sub>	Maximum Pulsed Drain to Source Diode Forward Current		-	-	-40	Α
V <sub>SD</sub>	Drain to Source Diode Forward Voltage	V <sub>GS</sub> =0V, I <sub>S</sub> = -15A	-	-0.8	-1.2	V
trr	Reverse Recovery Time	TJ=25℃,	-	64	-	ns
Qrr	Reverse Recovery Charge	$V_{DD}$ = -24V,I <sub>F</sub> =-2.8A, dI/dt=-100A/µs	ı	25	-	nC

Notes:1. Repetitive Rating: Pulse Width Limited by Maximum Junction Temperature

<sup>2.</sup> EAS condition: TJ=25  $^{\circ}\mathrm{C}$  , VGS=10V, RG=25  $\Omega$  , L=0.5mH, IAS=-12.7A

<sup>3.</sup> Pulse Test: Pulse Width≤300µs, Duty Cycle≤0.5%



## **Typical Characteristics**

Figure1: Output Characteristics

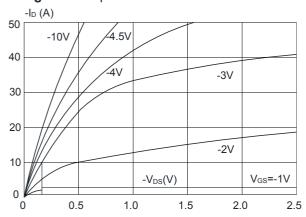


Figure 3:On-resistance vs. Drain Current

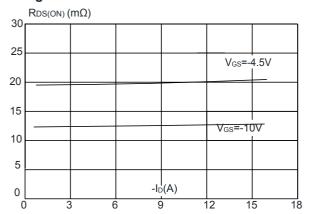


Figure 5: Gate Charge Characteristics

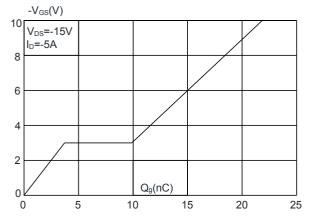


Figure 2: Typical Transfer Characteristics

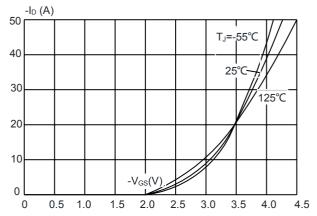


Figure 4: Body Diode Characteristics

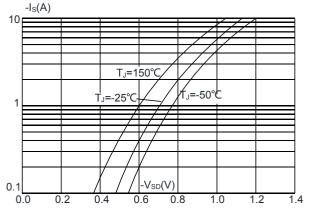
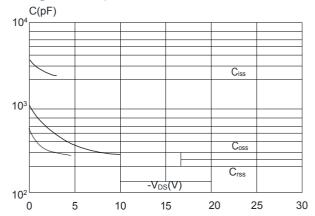


Figure 6: Capacitance Characteristics





**Figure 7:** Normalized Breakdown Voltage vs. Junction Temperature

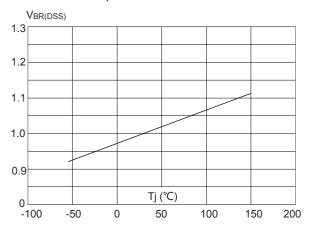
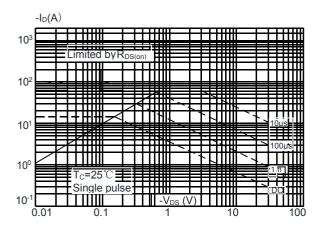
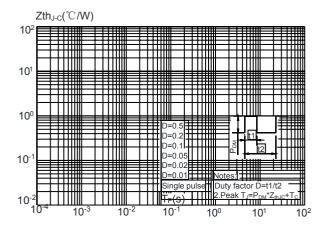


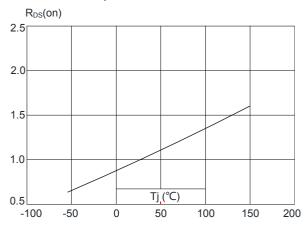
Figure 9: Maximum Safe Operating Area



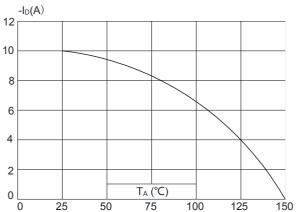
**Figure.11:** Maximum Effective Transient Thermal Impedance, Junction-to-Case



**Figure 8:** Normalized on Resistance vs. Junction Temperature

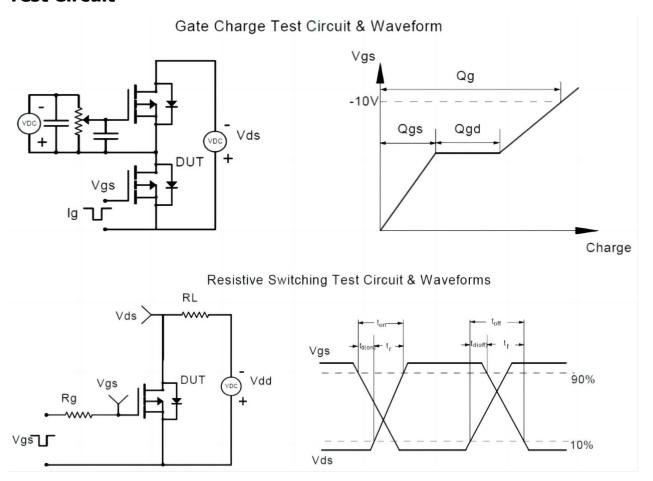


**Figure 10:** Maximum Continuous Drain Current vs. Ambient Temperature

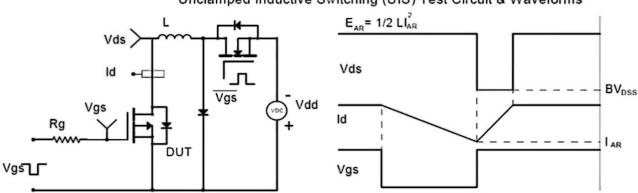




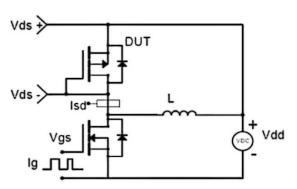
### **Test Circuit**

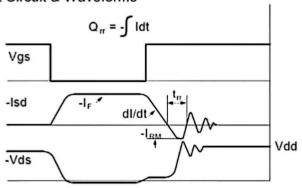


#### Unclamped Inductive Switching (UIS) Test Circuit & Waveforms



### Diode Recovery Test Circuit & Waveforms

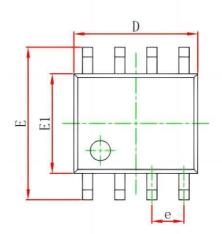


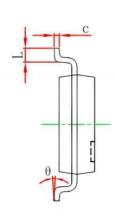


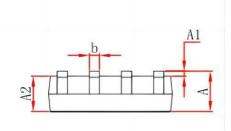


# **Package Outline Dimensions**

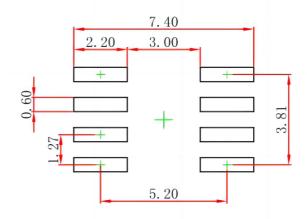
## SOP-8







Symbol	Dimensions In Millimeters		Dimensions In Inches	
Symbol	Min	Max	Min	Max
A	1.350	1.750	0.053	0.069
Al	0.100	0.250	0.004	0.010
A2	1.350	1.550	0.053	0.061
b	0.330	0.510	0.013	0.020
С	0.170	0. 250	0.007	0.010
D	4.800	5.000	0.189	0. 197
e	1.270 (BSC)		0.050 (BSC)	
E	5.800	6. 200	0. 228	0. 244
El	3.800	4.000	0.150	0. 157
L	0.400	1. 270	0.016	0.050
θ	0.0	8*	0.0	8°



#### Note:

- 1.Controlling dimension:in millimeters.
- 2.General tolerance:± 0.05mm.
- 3. The pad layout is for reference purposes only.



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